

EAST Search History

Ref #	Hits	Search Query	DBs	Default Operator	Plurals	Time Stamp
L1	550	716/21.ccls.	USPAT; EPO; JPO; DERWENT	OR	OFF	2006/07/24 06:50
L3	2	(light and path and lens and amplitude and mask and bias). clm.	US-PGPUB	OR	ON	2006/07/24 06:52
L4	2	(light and path and lens and amplitude and mask and bias). clm.	US-PGPUB	OR	ON	2006/07/24 06:52
L5	19	pupil with transmission with factor	USPAT; EPO; JPO; DERWENT	OR	OFF	2006/07/24 06:53
L6	250	mask adj bias	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	ON	2006/07/24 06:53
L7	4785	transmission adj factor	USPAT; EPO; JPO; DERWENT	OR	OFF	2006/07/24 06:53
L8	0	L6 same L7	USPAT; EPO; JPO; DERWENT	OR	OFF	2006/07/24 06:53
L9	2874	mask with bias	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	ON	2006/07/24 06:53
L10	1979	pupil with varia\$5	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	ON	2006/07/24 06:53
L11	1	L9 same L10	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	ON	2006/07/24 06:53
L12	13	L9 and L10	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	ON	2006/07/24 06:54
L13	2874	mask with bias	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	ON	2006/07/24 06:54
L14	29	L13 same amplitud\$5	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	ON	2006/07/24 06:54

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L15	5576	lithography and light with path	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	ON	2006/07/24 06:54
L16	875	zernike adj polynomial	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	ON	2006/07/24 06:54
L17	98	L16 and L15	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	ON	2006/07/24 06:54
L18	9023	lithography and bias	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	ON	2006/07/24 06:54
L19	25	L18 and L16	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	ON	2006/07/24 06:54
L20	1439	zernike	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	ON	2006/07/24 06:54
L21	19	pupil with transmission with factor	USPAT; EPO; JPO; DERWENT	OR	OFF	2006/07/24 06:54
L22	1	L21 and L20	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	ON	2006/07/24 06:54
L23	57	zernike and (430/5.ccls. or 716/19-21.ccls.)	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	ON	2006/07/24 06:54
L24	236	(transmittance adj characteristic). clm.	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	ON	2006/07/24 06:55
L25	250	mask adj bias	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	ON	2006/07/24 06:55
L26	1	L24 and L25	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	ON	2006/07/24 06:55

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L27	18873	within adj tolerance	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	ON	2006/07/24 06:55
L28	180	L27 with mask	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	ON	2006/07/24 06:55
L29	30	L28 same correct\$6	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	ON	2006/07/24 06:55
L30	1264	716/19.ccls.	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	ON	2006/07/24 06:55
S1	0	"pupil transmission factor variation"	USPAT; EPO; JPO; DERWENT	OR	OFF	2006/02/22 10:28
S3	0	pupil with transmission with factor with variation	USPAT; EPO; JPO; DERWENT	OR	OFF	2006/02/22 10:29
S5	19	pupil with transmission with factor	USPAT; EPO; JPO; DERWENT	OR	OFF	2006/02/22 10:32
S6	227	mask adj bias	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	ON	2006/02/22 10:33
S7	4689	transmission adj factor	USPAT; EPO; JPO; DERWENT	OR	OFF	2006/02/22 10:32
S9	0	S6 same S7	USPAT; EPO; JPO; DERWENT	OR	OFF	2006/02/22 10:33
S10	2679	mask with bias	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	ON	2006/02/22 10:39
S11	1	S10 same S7	USPAT; EPO; JPO; DERWENT	OR	OFF	2006/02/22 10:38
S12	1820	pupil with varia\$5	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	ON	2006/02/22 10:38

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S13	1	S10 same S12	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	ON	2006/02/22 10:40
S14	8	S10 and S12	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	ON	2006/02/27 13:51
S17	5058	lithography and light with path	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	ON	2006/02/27 15:12
S18	52	lithography and light with path with amplitud\$5	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	ON	2006/02/27 14:22
S21	5	lithography and light with amplitud\$5 with bias	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	ON	2006/02/27 14:24
S22	75	lithography and light with amplitud\$5 with angle	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	ON	2006/02/27 15:01
S23	2682	mask with bias	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	ON	2006/02/27 15:01
S24	28	S23 same amplitud\$5	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	ON	2006/02/27 15:10
S25	1306	zernike	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	ON	2006/02/27 16:03
S26	792	zernike adj polynomial	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	ON	2006/02/27 15:11
S27	83	S26 and S17	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	ON	2006/02/27 15:11
S28	8311	lithography and bias	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	ON	2006/02/27 15:13

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S29	16	S28 and S26	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	ON	2006/02/27 15:48
S30	229	lens same S26	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	ON	2006/02/27 15:48
S31	67	S30 and lithography	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	ON	2006/02/27 15:48
S32	1104	S25 and lens	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	ON	2006/02/27 16:05
S33	15	S32 and mask with bias	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	ON	2006/02/27 16:04
S34	19	pupil with transmission with factor	USPAT; EPO; JPO; DERWENT	OR	OFF	2006/02/27 16:06
S35	1	S34 and S25	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	ON	2006/02/27 16:06
S36	27	S26 and (430/5.ccls. or 716/19-21.ccls.)	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	ON	2006/02/27 16:35
S37	48	zernike and (430/5.ccls. or 716/19-21.ccls.)	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	ON	2006/02/27 16:35
S38	21	S37 not S36	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	ON	2006/02/27 16:39
S39	4755	focus with offset	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	ON	2006/02/27 16:39
S40	8	S39 same S25	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	ON	2006/03/06 07:21

EAST Search History

S45	26	simulat\$5 same point same segment and OPC	USPAT; EPO; JPO; DERWENT	OR	ON	2006/03/01 10:52
S46	1099	simulat\$5 same point same segment	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	ON	2006/03/01 10:52
S47	9631	opc	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	ON	2006/03/01 10:52
S48	59	S46 and S47	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	ON	2006/03/01 10:52
S49	3172	transmittance adj characteristic	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	ON	2006/03/06 07:22
S50	225	(transmittance adj characteristic). clm.	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	ON	2006/03/06 07:22
S51	228	mask adj bias	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	ON	2006/03/06 07:22
S52	1	S50 and S51	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	ON	2006/03/06 08:52
S53	18025	within adj tolerance	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	ON	2006/03/06 08:53
S54	169	S53 with mask	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	ON	2006/03/06 08:53
S55	1315	zernike	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	ON	2006/03/06 08:53
S56	0	S55 and S54	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	ON	2006/03/06 08:54

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S57	28	S54 same correct\$6	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	ON	2006/03/06 08:54
S58	706	716/19.ccls.	USPAT; EPO; JPO; DERWENT	OR	OFF	2006/07/24 06:50
S59	6375	430/5.ccls.	USPAT; EPO; JPO; DERWENT	OR	OFF	2006/03/06 09:27